- Multiplexed I/O Ports Provide Improved Bit Density
- Four Modes of Operation:
- Hold (Store)
- Shift Right
- Shift Left
- Load Data
- Operate With Outputs Enabled or at High Impedance
- 3-State Outputs Drive Bus Lines Directly
- Can Be Cascaded for n-Bit Word Lengths
- Direct Overriding Clear
- Applications:
- Stacked or Push-Down Registers
- Buffer Storage
- Accumulator Registers
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs


## description

These 8-bit universal shift/storage registers feature multiplexed I/O ports to achieve full 8-bit data handling in a single 20 -pin package. Two function-select (S0, S1) inputs and two outputenable ( $\overline{\mathrm{OE}}, \overline{\mathrm{OE} 2}$ ) inputs can be used to choose the modes of operation listed in the function table.

SN54ALS299 . . J PACKAGE
SN74ALS299... DW OR N PACKAGE
(TOP VIEW)

| S0 1 | $\cup^{20}$ |  |
| :---: | :---: | :---: |
| OE1 2 | 19 | $9]$ S1 |
| OE2 ${ }^{\text {c }} 3$ | 18 | 8 SL |
| $\mathrm{G} / \mathrm{Q}_{\mathrm{G}}$ | 17 | $\mathrm{l}^{\text {Q }} \mathrm{H}^{\prime}$ |
| E/QE 5 | 16 | $]^{\mathrm{H} / \mathrm{Q}_{\mathrm{H}}}$ |
| $\mathrm{C}^{\prime} \mathrm{Q}_{\mathrm{C}}$ | 15 | ${ }^{\text {F }} \mathrm{F} / \mathrm{Q}_{\mathrm{F}}$ |
| $\mathrm{A}^{\prime} \mathrm{Q}_{\mathrm{A}}{ }^{7}$ | 14 | ${ }^{\text {] }} \mathrm{D} / \mathrm{Q}_{\mathrm{D}}$ |
| $\mathrm{Q}_{\mathrm{A}^{\prime}}{ }^{\text {d }}$ | 13 | $3 \mathrm{~B} / \mathrm{Q}_{\mathrm{B}}$ |
| CLR [9 | 12 | ${ }^{\text {] CLK }}$ |
| GND 10 | 11 | 11 SR |

SN54ALS299... FK PACKAGE
(TOP VIEW)


Synchronous parallel loading is accomplished by taking both S0 and S1 high. This places the 3-state outputs in the high-impedance state and permits data applied on the I/O ports to be clocked into the register. Reading out of the register can be accomplished while the outputs are enabled in any mode. Clearing occurs asynchronously when the clear (CLR) input is low. Taking either OE1 or $\overline{\mathrm{OE} 2}$ high disables the outputs, but has no effect on clearing, shifting, or storing data.
The SN54ALS299 is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The SN74ALS299 is characterized for operation from $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$.

## 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS

WITH 3-STATE OUTPUTS
SDAS220B - DECEMBER 1982 -REVISED DECEMBER 1994
FUNCTION TABLE

| MODE | INPUTS |  |  |  |  |  |  |  | I/O PORTS |  |  |  |  |  |  |  | OUTPUTS |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | $\overline{C L R}$ | S1 | So | OE1 $\dagger$ | OE2 $\dagger$ | CLK | SL | SR | $A^{\prime} \mathbf{Q}_{\mathbf{A}}$ | $B / Q_{B}$ | $\mathrm{C} / \mathrm{Q}_{\mathrm{C}}$ | D/QD | $E / Q_{E}$ | F/Q $\mathrm{Q}_{\text {F }}$ | $\mathrm{G} / \mathrm{Q}_{\mathrm{G}}$ | $\mathrm{H} / \mathrm{Q}_{\mathrm{H}}$ | $\mathrm{Q}_{\mathbf{A}^{\prime}}$ | $\mathrm{Q}_{\mathrm{H}^{\prime}}$ |
| Clear | L | X | L | L | L | X | X | X | L | L | L | L | L | L | L | L | L | L |
|  | L | L | X | L | L | X | X | X | L | L | L | L | L | L | L | L | L | L |
|  | L | H | H | X | X | X | X | X | X | X | X | X | X | X | X | X | L | L |
| Hold | H | L | L | L | L | X | X | X | QA0 | QB0 | QC0 | QD0 | QE0 | QF0 | QG0 | QHo | QA0 | QH0 |
|  | H | X | X | L | L | L | X | X | QA0 | QB0 | QC0 | QD0 | QE0 | QF0 | QG0 | QH0 | QA0 | QH0 |
| Shift | H | L | H | L | L | $\uparrow$ | X | H | H | QAn | Q ${ }_{\text {Bn }}$ | QCn | QDn | QEn | QFn | $Q_{G n}$ | H | $Q_{G n}$ |
| Right | H | L | H | L | L | $\uparrow$ | X | L | L | $Q_{\text {An }}$ | QBn | $Q_{C n}$ | Q ${ }_{\text {Dn }}$ | QEn | QFn | $Q_{G n}$ | L | $Q_{G n}$ |
| Shift | H | H | L | L | L | $\uparrow$ | H | X | QBn | $Q_{C n}$ | QDn | QEn | $Q_{\text {Fn }}$ | $Q_{G n}$ | QHn | H | Q ${ }_{\text {Bn }}$ | H |
| Left | H | H | L | L | L | $\uparrow$ | L | X | QBn | $Q_{C n}$ | QDn | QEn | QFn | $Q_{G n}$ | QHn | L | QBn | L |
| Load | H | H | H | X | X | $\uparrow$ | X | X | a | b | c | d | e | f | g | h | a | h |

NOTE: $a \ldots$. $\mathrm{h}=$ the level of the steady-state input at inputs A through H , respectively. This data is loaded into the flip-flops while the flip-flop outputs are isolated from the I/O terminals.
$\dagger$ When one or both output-enable inputs are high, the eight I/O terminals are disabled to the high-impedance state; however, sequential operation or clearing of the register is not affected.

## logic symbol $\ddagger$


$\ddagger$ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
logic diagram (positive logic)

$\dagger I / O$ ports not shown: $B / Q_{B}(13), C / Q_{C}(6), D / Q_{D}(14), E / Q_{E}(5), F / Q_{F}(15)$, and $G / Q_{G}(4)$.
absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\ddagger$


I/O ports ....................................................................................... 5.5 V

SN74ALS299 ....................................... $0^{\circ} \mathrm{C}$ to $70^{\circ} \mathrm{C}$
Storage temperature range $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$
$\ddagger$ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 8-BIT UNIVERSAL SHIFT/STORAGE REGISTERS

## WITH 3-STATE OUTPUTS

SDAS220B - DECEMBER 1982 - REVISED DECEMBER 1994

## recommended operating conditions

|  |  |  |  | 4ALS2 |  |  | 4ALS2 |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | NOM | MAX | MIN | NOM | MAX |  |
| $\mathrm{V}_{\mathrm{CC}}$ | Supply voltage |  | 4.5 | 5 | 5.5 | 4.5 | 5 | 5.5 | V |
| $\mathrm{V}_{\text {IH }}$ | High-level input voltage |  | 2 |  |  | 2 |  |  | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-level input voltage |  |  |  | 0.7 |  |  | 0.8 | V |
|  | h-level output current | $\mathrm{Q}_{\mathrm{A}^{\prime}}$ or $\mathrm{Q}_{H^{\prime}}$ |  |  | -0.4 |  |  | -0.4 | mA |
|  | High-level ouput current | $Q_{A}-Q_{H}$ |  |  | -1 |  |  | -2.6 |  |
|  | Low-level output current | $Q_{A^{\prime}}$ or $Q_{H^{\prime}}$ |  |  | 4 |  |  | 8 | mA |
|  | Low-level output curren | $Q_{A}-Q_{H}$ |  |  | 12 |  |  | 24 |  |
| $\mathrm{T}_{\mathrm{A}}$ | Operating free-air temper |  | -55 |  | 125 | 0 |  | 70 | ${ }^{\circ} \mathrm{C}$ |

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)


$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ For $\mathrm{I} / \mathrm{O}$ ports $\left(\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}\right)$, the parameters $\mathrm{I}_{\mathrm{IH}}$ and $\mathrm{I}_{\mathrm{IL}}$ include the off-state output current.
§ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.
timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

$\dagger$ Inactive-state setup time is also referred to as recovery time.
switching characteristics (see Figure 1)

| PARAMETER | FROM (INPUT) | то (OUTPUT) | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=4.5 \mathrm{~V} \text { to } 5.5 \mathrm{~V}, \\ & \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \\ & \mathrm{R} 1=500 \Omega, \\ & \mathrm{R} 2=500 \Omega, \\ & \mathrm{~T}_{\mathrm{A}}=\operatorname{MIN} \text { to MAX } \ddagger \end{aligned}$ |  |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | SN54ALS299 |  | SN74ALS299 |  |  |
|  |  |  | MIN | MAX | MIN | MAX |  |
| $f_{\text {max }}$ |  |  | 17 |  | 30 |  | MHz |
| tPLH | CLK | $\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}$ | 2 | 19 | 4 | 13 | ns |
| tPHL |  |  | 4 | 25 | 7 | 19 |  |
| tPLH | CLK | $\mathrm{Q}_{\mathrm{A}^{\prime}}$ or $\mathrm{Q}_{\mathrm{H}^{\prime}}$ | 2 | 21 | 5 | 15 | ns |
| tPHL |  |  | 4 | 25 | 8 | 18 |  |
| tPHL | $\overline{\text { CLR }}$ | $\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}$ | 6 | 29 | 6 | 22 | ns |
|  |  | $\mathrm{Q}_{\mathrm{A}^{\prime}}$ or $\mathrm{Q}_{\mathrm{H}^{\prime}}$ | 6 | 29 | 6 | 22 |  |
| tPZH | $\overline{O E 1}, \overline{O E 2}$ | $\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}$ | 5 | 22 | 6 | 16 | ns |
| tPZL |  |  | 6 | 27 | 8 | 22 |  |
| tPZH | S0, S1 | $Q_{A}-Q_{H}$ | 5 | 27 | 7 | 17 | ns |
| tPZL |  |  | 6 | 26 | 8 | 22 |  |
| tPHZ | $\overline{\mathrm{OE}}, \overline{\mathrm{OE} 2}$ | $\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}$ | 1 | 15 | 1 | 8 | ns |
| tplZ |  |  | 4 | 38 | 5 | 15 |  |
| tPHZ | S0, S1 | $\mathrm{Q}_{\mathrm{A}}-\mathrm{Q}_{\mathrm{H}}$ | 1 | 16 | 1 | 12 | ns |
| tPLZ |  |  | 4 | 34 | 8 | 25 |  |

$\ddagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S 1 is open.
D. All input pulses have the following characteristics: $\mathrm{PRR} \leq 1 \mathrm{MHz}, \mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=2 \mathrm{~ns}$, duty cycle $=50 \%$.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

## PACKAGING INFORMATION

| Orderable Device | Status <br> (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan <br> (2) | Lead/Ball Finish <br> (6) | MSL Peak Temp <br> (3) | Op Temp ( ${ }^{\circ} \mathrm{C}$ ) | Device Marking <br> (4/5) | Samples |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 83021012A | ACTIVE | LCCC | FK | 20 | 1 | TBD | POST-PLATE | N / A for Pkg Type | -55 to 125 | 83021012A <br> SNJ54ALS <br> 299FK | Samples |
| 8302101RA | ACTIVE | CDIP | J | 20 | 1 | TBD | Call TI | N / A for Pkg Type | -55 to 125 | 8302101RA SNJ54ALS299J | Samples |
| 8302101SA | ACTIVE | CFP | W | 20 | 1 | TBD | Call TI | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 8302101SA } \\ & \text { SNJ54ALS299W } \end{aligned}$ | Samples |
| SN74ALS299DW | ACTIVE | SOIC | DW | 20 | 25 | Green (RoHS \& no $\mathrm{Sb} / \mathrm{Br}$ ) | NIPDAU | Level-1-260C-UNLIM | 0 to 70 | ALS299 | Samples |
| SN74ALS299N | ACTIVE | PDIP | N | 20 | 20 | Pb-Free (RoHS) | NIPDAU | N/ A for Pkg Type | 0 to 70 | SN74ALS299N | Samples |
| SNJ54ALS299FK | ACTIVE | LCCC | FK | 20 | 1 | TBD | POST-PLATE | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 83021012A } \\ & \text { SNJ54ALS } \\ & \text { 299FK } \\ & \hline \end{aligned}$ | Samples |
| SNJ54ALS299J | ACTIVE | CDIP | J | 20 | 1 | TBD | Call TI | N / A for Pkg Type | -55 to 125 | 8302101RA SNJ54ALS299J | Samples |
| SNJ54ALS299W | ACTIVE | CFP | W | 20 | 1 | TBD | Call TI | N / A for Pkg Type | -55 to 125 | $\begin{aligned} & \text { 8302101SA } \\ & \text { SNJ54ALS299W } \end{aligned}$ | Samples |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the $<=1000 \mathrm{ppm}$ threshold requirement.
${ }^{(3)}$ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
${ }^{(4)}$ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
${ }^{(5)}$ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
${ }^{(6)}$ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width

Important Information and Disclaimer:The information provided on this page represents Tl's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## OTHER QUALIFIED VERSIONS OF SN54ALS299, SN74ALS299 :

- Catalog: SN74ALS299
- Military: SN54ALS299

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

W (R-GDFP-F20)


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only.
E. Falls within Mil-Std 1835 GDFP2-F20

FK (S-CQCC-N**)
LEADLESS CERAMIC CHIP CARRIER 28 TERMINAL SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. Falls within JEDEC MS-004


| DIM PINS ** | 14 | 16 | 18 | 20 |
| :---: | :---: | :---: | :---: | :---: |
| A | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC | 0.300 <br> $(7,62)$ <br> BSC |
| B MAX | 0.785 <br> $(19,94)$ | .840 <br> $(21,34)$ | 0.960 <br> $(24,38)$ | 1.060 <br> $(26,92)$ |
| B MIN | - | - | - | - |
| C MAX | 0.300 <br> $(7,62)$ | 0.300 <br> $(7,62)$ | 0.310 <br> $(7,87)$ | 0.300 <br> $(7,62)$ |
| C MIN | 0.245 <br> $(6,22)$ | 0.245 <br> $(6,22)$ | 0.220 <br> $(5,59)$ | 0.245 <br> $(6,22)$ |



NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package is hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)
PLASTIC DUAL-IN-LINE PACKAGE
16 PINS SHOWN


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C) Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).

D The 20 pin end lead shoulder width is a vendor option, either half or full width.


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side
5. Reference JEDEC registration MS-013.


NOTES: (continued)
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.


SOLDER PASTE EXAMPLE BASED ON 0.125 mm THICK STENCIL

SCALE:6X

NOTES: (continued)
8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

## IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.
These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Tl grants you permission to use these resources only for development of an application that uses the Tl products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify Tl and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.
Tl's products are provided subject to Tl's Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such TI products. Tl's provision of these resources does not expand or otherwise alter Tl's applicable warranties or warranty disclaimers for TI products.

